


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/057,026	CHEN ET AL.	
	Examiner	Art Unit	
	Ly T. TRAN	2853	

SEARCHED			
Class	Subclass	Date	Examiner
347	61-63,65	5/26/2005	LT
347	54,56,48	5/26/2005	LT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Stephens Juanita Huffman	5/25/2005	LT